

Spring-loaded test probe

GKS-075 303 120 A 2000 C

Item GKS-075-0366



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Partner for Future Technology

- Well-established test probes for contacting PCBs
- For optimal contact to the test points (e.g. pads, vias, and pins), various tip styles with various diameters and finishes are available.
- Various spring forces available as well as versions with stainless steel springs suitable for high temperatures

General data

Product group	ICT / FCT (in-circuit test and function test)
Sub-product group	Standard stroke test probe
Series	GKS-075
Grid	1.91 mm [75 mil]
Contacting from	Pin, Post
Magnetic	Yes
Installation type	Plug-in
Quick-exchange system	Yes
Adjustable installation height	No
Non-rotating	No
Compatible receptacle(s)	KS-075
Min. temperature	- 100 °C [- 212 °F]
Max. temperature	+ 200 °C [+ 392 °F]
RoHS-compliant	RoHS-3;6c

Electrical data

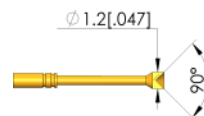
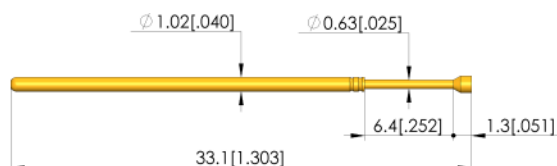
Current load capacity / rated current	4 A
Typical resistance (Ri)	<100 mOhm

Mechanical data

Total length	33.1 mm [1.30 in]
Barrel diameter	1.02 mm [.040 in]
Maximum stroke	6.35 mm [.25 in]
Spring pre-load	0.66 N [2.37 ozf]
Collar height	00
Spring force at working stroke	2 N [7.19 ozf]
Recommended working stroke	4.3 mm [.169 in]

Tip style data

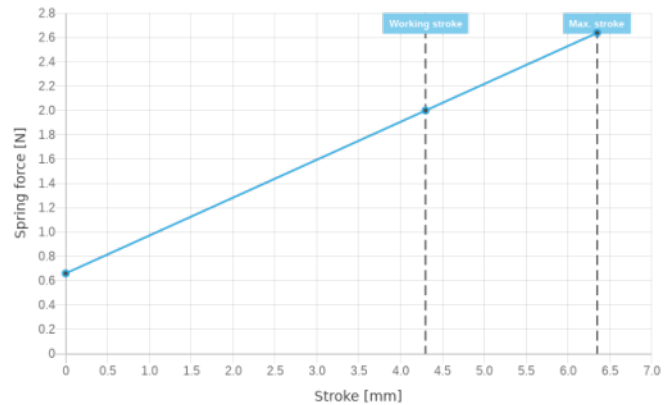
Tip style	03 inverse cone
Tip diameter	1.2 mm [.047 in]
Tip style surface	A gold
Tip style material	3 CuBe



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Prices and delivery times on request.
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Learn more about
ICT/FCT Test probes

